



STTH20LCD06C

Turbo2 ultrafast - high voltage rectifier for SMPS

Features

- ultrafast switching
- low reverse current
- low thermal resistance
- reduces conduction and switching losses

Description

The STTH20LCD06C uses ST Turbo2 technology. This device is specially suited for switching power supplies working with interleaved PFCs.

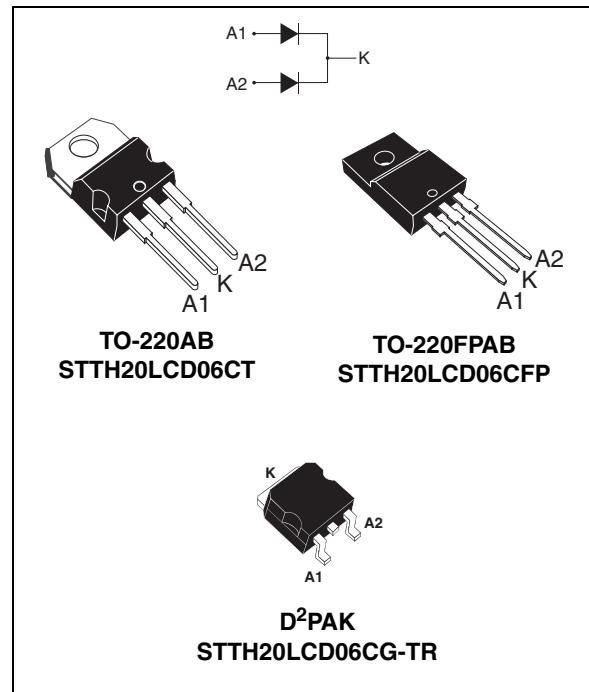


Table 1. Device summary

$I_{F(AV)}$	2 x 10 A
V_{RRM}	600 V
T_j	175 °C
V_F (typ)	1.25 V
t_{rr} (max)	50 ns

1 Characteristics

Table 2. Absolute ratings⁽¹⁾

Symbol	Parameter				Value	Unit			
V_{RRM}	Repetitive peak reverse voltage				600	V			
$I_{F(RMS)}$	Forward current rms				30	A			
$I_{F(AV)}$	Average forward current, $\delta = 0.5$	$T_c = 105^\circ\text{C}$	TO-220AB, D ² PAK	Per diode	10	A			
				Per device	20	A			
	$T_c = 60^\circ\text{C}$	TO-220FPAB	Per diode	10	A				
			Per device	20	A				
I_{FSM}	Surge non repetitive forward current	$t_p = 10 \text{ ms sinusoidal}$			80	A			
T_{sig}	Storage temperature range				-65 to + 175	°C			
T_j	Maximum operating junction temperature ⁽²⁾				175	°C			

1. Limiting values per diode at 25 °C, unless otherwise specified
2. $\frac{dP_{tot}}{dT_j} < \frac{1}{R_{th(j-a)}}$ condition to avoid thermal runaway for a diode on its own heatsink

Table 3. Thermal resistance

Symbol	Parameter		Value	Unit
$R_{th(j-c)}$	Junction to case		TO-220AB, D ² PAK	3.5
	TO-220FPAB		5.8	

Table 4. Static electrical characteristics

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
$I_R^{(1)}$	Reverse leakage current	$T_j = 25^\circ\text{C}$	$V_R = V_{RRM}$	-	-	1	μA
		$T_j = 150^\circ\text{C}$		-	10	100	
$V_F^{(2)}$	Forward voltage drop	$T_j = 25^\circ\text{C}$	$I_F = 10 \text{ A}$	-	-	2	V
		$T_j = 150^\circ\text{C}$		-	1.25	1.6	
		$T_j = 25^\circ\text{C}$	$I_F = 20 \text{ A}$	-	-	2.35	
		$T_j = 150^\circ\text{C}$		-	1.55	2	

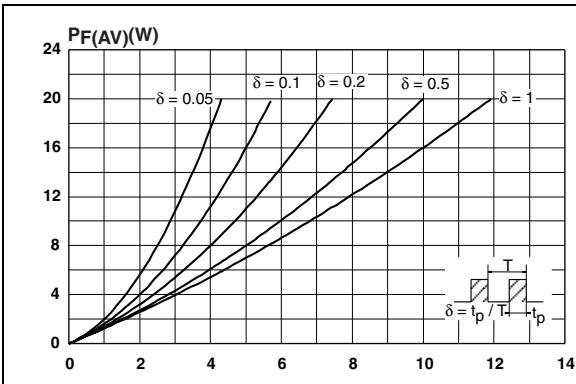
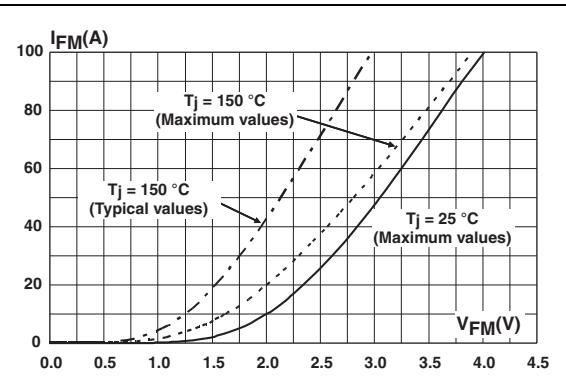
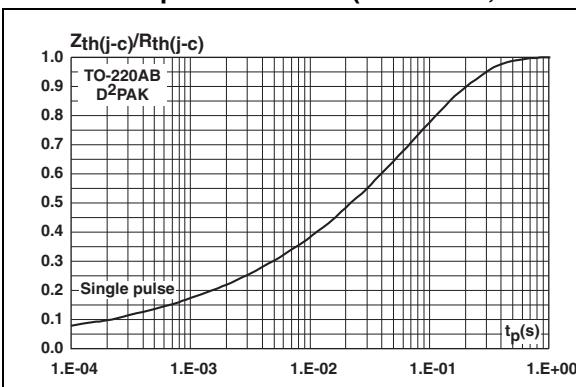
1. Pulse test: $t_p = 5 \text{ ms}$, $\delta < 2 \%$
2. Pulse test: $t_p = 380 \text{ } \mu\text{s}$, $\delta < 2 \%$

To evaluate the conduction losses use the following equation:

$$P = 1.2 \times I_{F(AV)} + 0.04 \times I_F^2 \text{ (RMS)}$$

Table 5. Dynamic electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{rr}	Reverse recovery time	$I_F = 0.5 \text{ A}, I_{rr} = 0.25 \text{ A}, I_R = 1 \text{ A}, T_j = 25^\circ\text{C}$			25	ns
		$I_F = 1 \text{ A}, dI_F/dt = -50 \text{ A}/\mu\text{s}, V_R = 30 \text{ V}, T_j = 25^\circ\text{C}$		35	50	
I_{RM}	Reverse recovery current	$I_F = 10 \text{ A}, dI_F/dt = -50 \text{ A}/\mu\text{s}, V_R = 400 \text{ V}, T_j = 125^\circ\text{C}$		2	2.8	A
t_{fr}	Forward recovery time	$I_F = 10 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}, V_{FR} = 1.1 \times V_{Fmax}, T_j = 25^\circ\text{C}$			230	ns
V_{FP}	Forward recovery voltage	$I_F = 10 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}, V_{FR} = 1.1 \times V_{Fmax}, T_j = 25^\circ\text{C}$		4		V

Figure 1. Average forward power dissipation versus average forward current (per diode)**Figure 2. Forward voltage drop versus forward current (per diode)****Figure 3. Relative variation of thermal impedance junction to case versus pulse duration (TO-220AB, D²PAK)****Figure 4. Relative variation of thermal impedance junction to case versus pulse duration (TO-220FPAB)**